## Notice of References Cited Application/Control No. 10/609,635 Examiner Juan D. Valentin II Applicant(s)/Patent Under Reexamination TAKAHASHI ET AL. Page 1 of 1

## **U.S. PATENT DOCUMENTS**

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Name	Classification
*	Α	US-2003/0053742 A1	03-2003	Maruyama, Tsukuru	385/18
*	В	US-5,705,810 A1	01-1998	Wang et al.	356/152.3
*	С	US-5,185,676 A1	02-1993	Nishiberi, Nozomu	356/141.3
*	D	US-6,975,389 B2	12-2005	Takahashi, Koichi	356/139
*	ε	US-4,984,892 A1	01-1991	Hofmann, Otto	356/625
*	F	US-5,784,168 A1	07-1998	Ophey et al.	356/615
*	G	US-5,815,255 A1	09-1998	Van Ochten et al.	356/138
*	Н	US-6,333,910	12-2001	Nishikawa et al.	369/119
*	-	US-6,404,485	06-2002	Kubo et al.	356/138
*	٦	US-6,480,289	11-2002	Shimomura et al.	356/614
	К	US-			
	L	US-			
	М	US-			

## **FOREIGN PATENT DOCUMENTS**

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Country	Name	Classification
	N					,
	0					
	Ρ					
	Q					
	R					
	S					
	T					

## **NON-PATENT DOCUMENTS**

*		Include as applicable: Author, Title Date, Publisher, Edition or Volume, Pertinent Pages)					
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	V						
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	х						

\*A copy of this reference is not being furnished with this Office action. (See MPEP § 707.05(a).)

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